| L Number | Hits | Search Text | DB | Time stamp |
|----------|------|---|-----------|------------------|
| 3 | 1 | surface and rz and ra and sm and pc | EPO; JPO; | 2004/08/14 19:34 |
| | | | DERWENT, | |
| | | | IBM_TDB | |
| 4 | 1 | surface and rz and ra and sm and peak adj count | EPO; JPO; | 2004/08/14 19:34 |
| | | | DERWENT; | |
| | | | IBM_TDB | |
| 5 | 19 | surface and rz and ra and sm | EPO; JPO; | 2004/08/14 19:39 |
| | | | DERWENT; | |
| | | | IBM_TDB | |
| 6 | 20 | rz and ra and sm | EPO; JPO; | 2004/08/14 19:40 |
| | | | DERWENT; | |
| | | | IBM_TDB | 1 |
| 7 | 1 | (rz and ra and sm) not (surface and rz and ra and sm) | EPO; JPO; | 2004/08/14 19:40 |
| | | | DERWENT; | |
| | _ | | IBM_TDB | |
| 8 | 2 | optical adj interferometry and roughness | EPO; JPO; | 2004/08/14 19:42 |
| | | | DERWENT; | |
| | | | IBM_TDB | |
| 9 | 592 | interference and roughness | EPO; JPO; | 2004/08/14 19:42 |
| | | | DERWENT; | |
| | | | IBM_TDB | |
| 10 | 134 | interference and roughness and electrophoto\$ | EPO; JPO; | 2004/08/14 19:43 |
| | | | DERWENT; | |
| | | | IBM_TDB | |
| 11 | 32 | interference and roughness and electrophoto\$ and thickness | EPO; JPO; | 2004/08/14 19:43 |
| | | | DERWENT; | |
| | | | IBM TDB | |